

Supplementary information

Working Area Effects on the Energetic Distribution of Trap States and Charge Dynamics of Dye-Sensitized Solar Cells

Wei Yan^[a], Ming-Ming Huo^{*,[a]}, Rong Hu^[b], Yong Wang^[a]

[a], Laser Research Institute, Qilu University of Technology (Shandong Academy of Sciences), Qingdao, Shandong, 266100, China;

[b], Research Institute for New Materials Technology, Chongqing University of Arts and Sciences, Chongqing, 402160, China.

S1. Theoretical derivation of chemical capacitance

When the quasi-Fermi level (E_{Fn}) of a dye-sensitized solar cell is much lower than the band edge energy of conduction band (E_{cb}) of its TiO_2 photoanode, the chemical capacitance (C_μ) is dominated by the trap state distribution. C_μ can be written as^[S1]:

$$C_\mu = e^2 \frac{\partial n_T}{\partial E_{Fn}} \quad (s1)$$

where e is the unit charge, n_T is the density of trapped electrons. At this time, the chemical capacitance reflects the capability of a system to accept or release additional trapped electrons with density n_T due to a change of quasi-Fermi level.

n_T can be written as^[S2]

$$n_T = \int_{E_{vb}}^{E_{cb}} g_T(E) f(E, E_{Fn}) dE = N_T \exp\left[\frac{E_{Fn} - E_{cb}}{k_B T_T}\right] \quad (s2)$$

Where E_{vb} is the band edge energy of the valence band, $g_T(E)$ is the density of trap states as a function of energy E , $f(E, E_{Fn})$ is the Fermi-Dirac function, N_T and T_T are the total density and the characteristic temperature of the trap states.

For trapped electrons in Boltzmann distribution, C_μ can be expressed as^[S3]

$$C_\mu = e^2 \frac{N_T}{k_B T_T} \exp\left[\frac{E_{Fn} - E_{cb}}{k_B T_T}\right] \quad (s3)$$

Because of $V_{ph} = (E_{Fn} - E_{redox})/e$, E_{redox} is the redox energy of electrolyte. Eq. (s3) can be expressed as

$$C_\mu = e^2 \left[B \exp\left(\frac{e}{k_B T_T} V_{ph}\right) \right] \quad (s4)$$

So C_μ is exponentially dependent on V_{ph} . The pre-exponential factors B is

$$B = \frac{N_T}{k_B T_T} \exp\left(\frac{E_{redox} - E_{cb}}{k_B T_T}\right) \quad (s5)$$

References

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